Search Notes



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Examiner

Nguyen, Jennifer T

Applicant(s)/Patent Under Reexamination

TAKAHASHI ET AL.

Art Unit

2629

SEARCHED

Class	Subclass	Date	Examiner
345	173,177	5/25/07	JN

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east search, PAJ	5/25/07	JN

INTERFERENCE SEARCH

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178	18.01,18.03	5/25/07	JN

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